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APPLICATION NUMBER: 60/353,849 FILING DATE: February 01, 2002

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HIGH SPEED ENHANCED RESPONSIVITY PHOTO DETECTOR

BACKGROUND

There is a well-known tradeoff between high speed and sensitivity in a photodetector. High bandwidth requires a short transit time and thus a thin absorber layer, which results in a reduced absorption and lower responsivity. This proposal describes a way around this problem, with an enhanced absorption photodetector design.

The closest previous detector is the "uni-traveling carrier" ("UTC") detector. This is substantially different as follows:

The UTC detector has the entire absorption region heavily doped with no low doped drift absorption region where the carriers travel with their saturation velocity.

The UTC detector has a collector region in a high bandgap region which has no absorption and where the electrons do travel with saturation velocity. The detector discussed here has no high bandgap region where there is no absorption, and thus no drift region without absorption.

Because of this electron drift region, the UTC detector has several carefully designed interface layers and interface doping to optimally adjust the bandgap discontinuity between the low gap absorption and high gap drift regions. The detector discussed here needs no such layers.

Because there is no "wasted" drift region without absorption, the enhanced detector discussed in this patent is expected to have a superior performance at high speeds such as 40Gb/s.

DESCRIPTION

In an embodiment of the present invention, in the enhanced photodetector, the heavily doped p anode region in the absorption region of the detector (e.g. PIN, APD etc.) is concentration graded from a high p concentration near the anode to a lower p concentration towards the cathode. By grading the doping in this way, a pseudo-field is created which gives the electrons a very high velocity in this highly doped region, even higher than their saturation velocity in the low doped drift region.

The operation of this detector is summarized as follows:

The light is absorbed in the low bandgap absorption region (e.g. InGaAs) of the detector. The light which is absorbed in the low doped (high field) part of the absorber produces electrons and holes that drift to the anode (holes) and cathode (electrons) under the influence of the large drift electric field. This field is so large that both the electrons and holes reach their saturation velocities. This is the usual situation in standard uniformly low doped absorber PIN photodetectors. In the enhanced detector, however, the photoresponse is more complex.

The electrons generated in this low doped part of the absorber reach the cathode with their saturation velocity and are collected as usual. The holes generated in this low doped part of the absorption region reach the edge of the absorption region where the doping starts to become high and where they can be electromagnetically collected in a very short dielectric relaxation time (typically requiring a doping of ~10¹⁶), thus ending their transit time. Since the dielectric relaxation is so short, the holes do not have to

transit all the way across the heavily doped p region, and thus, their transit time is the same as if the extra p absorber material was not there.

The light that is absorbed in the heavily doped p region also produces electrons and holes. These holes are collected electromagnetically which is essentially instantaneously, and thus do not add substantially to the transit time or reduce the detector bandwidth either in the high-doped or the low doped absorber regions.

The electrons generated in this highly doped region are subject to the pseudo-field created by the doping gradient.

$$F = -(kT/q) dp/dx$$

This pseudo-field F is designed so that it produces an "overshoot" electron velocity, i.e. the electron velocity can be made to be many times faster than the saturation velocity. For example, in an exponential gradient

$$p = p_0 \exp(-x/L)$$

with L=800Å yields a field F=3.25kV/cm. (Typical electron saturation velocities are only ~5x10⁶ cm/sec, whereas overshoot velocities can be as large as ~4x10⁷ cm/sec at fields F of the magnitude given above). Thus, the electrons can quickly escape from this heavily p doped absorption region, adding little to the transit time.

In summary, an extra absorption region if properly doped can be added to the drift region in the low bandgap absorber without substantially increasing the transit time or the capacitance, i.e. without substantially reducing the overall bandwidth. Of course, it may

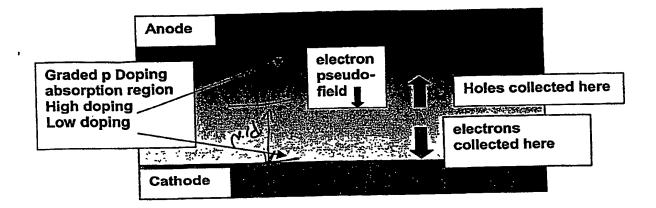
be advantageous to optimize the overall speed by adjusting the doping, the capacitance and the total thickness of the absorption region.

As an illustrative example of one embodiment of the present invention only: A standard 0.6 micron thick absorption layer PIN with low doping has a transit time limited bandwidth of ~50 GHz. For comparison, this same transit time bandwidth can be achieved with a 0.8 micron thick absorption layer with an exponentially graded p doping (L=800Å). Thus, in this example, the single pass responsivity is increased from 34% to 42% (an improvement of 24%) while keeping the transit time limited bandwidth approximately constant. For a mirror reflectivity of 70% the responsivity improvement is from 49% to 59% (an improvement of 20%).



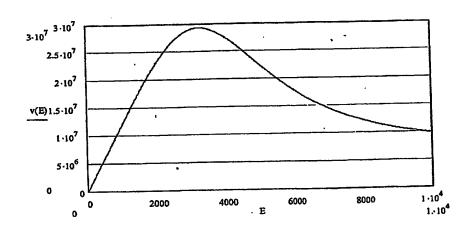
FIGURE

Graded p-Doping Enhanced Absorption Detector



Frome 2

Electron Overshoot Velocity



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